


<b>Search Notes</b>  	<b>Application/Control No.</b>  10811222	<b>Applicant(s)/Patent Under Reexamination</b>  CHAO ET AL.
	<b>Examiner</b>  TIPHANY B DICKERSON	<b>Art Unit</b>  3623

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Searched capacity planning in semiconductor manufacturing environment	1/8/2009	TBD
capacity planning with upgrade technology	1/8/2009	TBD

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/TIPHANY B DICKERSON/ Examiner.Art Unit 3623	
---	--